

Notice of References Cited

Application/Control No.

10/507,005

Applicant(s)/Patent Under
Reexamination
ARANYI ET AL.

Examiner

Nyeemah Grazier

Art Unit

1626

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	C	US-2005/0176771 A1	08-2005	Hayakawa et al.	514/326
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